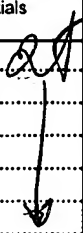


INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Complete if Known	
				Application Number	
				Filing Date	Herewith
				First Named Inventor	Hayden
				Art Unit	
Examiner Name					
Sheet	1	of	2	Attorney's Docket No.	TAL:1016.2023



U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines where passages or relevant figures appear
		Number - Kind Code (if known)			
	AA	US- 4697143	09-29-1987	Lockwood et al.	
	AB	US- 4891584	01-02-1990	Kamieniecki et al.	
	AC	US- 5506515	04-09-1996	Godshalk et al.	
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	AG	US-			
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	AI	US-			
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	AK	US-			
	AL	US-			
	AM	US-			
	AN	US-			
	AO	US-			
	AP	US-			
	AQ	US-			
	AR	US-			
	AS	US-			
AT	US-				
AU	US-				

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No. ¹	Foreign Patent Documents	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, columns, lines where passages or relevant figures appear	T ¹
		Country Code - Number - Kind Code				
	BA	JP-55115383-A2	09-05-1980	Mitsubishi Electric Corp.	Abstract, figures	✓
	BB	JP-57075480	05-12-1982	NEC Corp.	Abstract	✓
	BC					
	BD					
	BE					
	BF					
	BG					
	BH					
	BI					
	BJ					

Examiner Signature		Date Considered	3/17/04
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Applicant is to place a check mark here if English language translation is attached.

INFORMATION DISCLOSURE STATEMENT BY APPLICANT				C mplete If Known	
				Application Number	
				Filing Date	Herewith
				First Named Inventor	Hayden
				Art Unit	
				Examiner Name	
Sheet	2	of	2	Attorney's Docket No.	TAL:1016.2023

OTHER PRIOR ART-NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. ¹	Include name of author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and or country where published	T ²
 	CA	"Air Coplanar™ Probe Series," 2000, Cascade Microtech Inc., Beaverton, Oregon.	
	CB	"Electro-Optical Component Test," 2001, Cascade Microtech Inc., Beaverton, Oregon.	
	CC	"Laser Diode Test Solution," unknown, www.cascademicrotech.com/index.cfm/fuseaction/pg.view/pID/136, Cascade Microtech Inc., Beaverton, Oregon.	
	CD		
	CE		
	CF		
	CH		
	CI		
	CJ		
	CK		

Examiner Signature		Date Considered	3/17/24
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² Applicant is to place a check mark here if English language translation is attached.